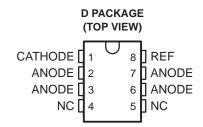
- Equivalent Full-Range Temperature Coefficient . . . 30 ppm/°C
- 0.2-Ω Typical Output Impedance
- Sink-Current Capability . . . 1 mA to 100 mA
- Low Output Noise
- Adjustable Output Voltage . . . V_{ref} to 36 V
- Available in a Wide Range of High-Density Packages

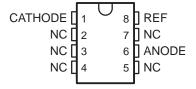
description

The TL431 and TL431A are three-terminal adjustable shunt regulators with specified thermal stability over applicable automotive, commercial, and military temperature ranges. The output voltage can be set to any value between V_{ref} (approximately 2.5 V) and 36 V with two external resistors (see Figure 17). These devices have a typical output impedance of 0.2 Ω . Active output circuitry provides a very sharp turn-on characteristic, making these devices excellent replacements for Zener diodes in many applications, such as onboard regulation, adjustable power supplies, and switching power supplies.

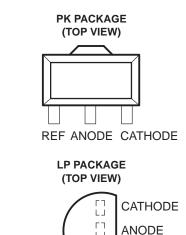
The TL431C and TL431AC are characterized for operation from 0°C to 70°C, and the TL431I and TL431AI are characterized for operation from -40°C to 85°C.

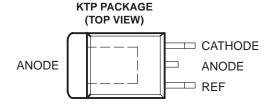


P OR PW PACKAGE (TOP VIEW)



NC - No internal connection





REF



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

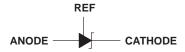


AVAILABLE OPTIONS

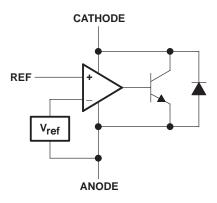
	PACKAGED DEVICES								
TA	SMALL OUTLINE (D)	PLASTIC FLANGE MOUNT (KTP)	TO-226AA (LP)	PLASTIC DIP (P)	SOT-89 (PK)	SHRINK SMALL OUTLINE (PW)	CHIP FORM (Y)		
0°C to 70°C	TL431CD TL431ACD	TL431CKTPR	TL431CLP TL431ACLP	TL431CP TL431ACP	TL431CPK	TL431CPW	TL431Y		
-40°C to 85°C	TL431ID TL431AID		TL431ILP TL431AILP	TL431IP TL431AIP	TL431IPK		114311		

The D and LP packages are available taped and reeled. The KTP and PK packages are only available taped and reeled. Add the suffix R to device type (e.g., TL431CDR). Chip forms are tested at $T_A = 25^{\circ}$ C.

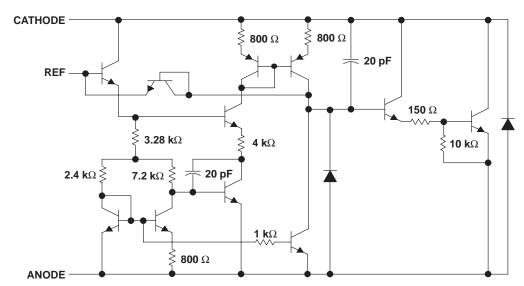
symbol



functional block diagram



equivalent schematic†



† All component values are nominal.



TL431, TL431A ADJUSTABLE PRECISION SHUNT REGULATORS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Cathode voltage, V _{KA} (see Note 1)		37 V
Continuous cathode current range, I _{KA}		
Reference input current range		
Package thermal impedance, θ_{JA} (see Notes 2 and 3):		•
1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1	LP package	
	KTP package	
	P package	
	PK package	
	PW package	149°C/W
Lead temperature 1,6 mm (1/16 inch) from case for 10	seconds: D, P, or PW package .	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 60	seconds: LP or PK package	300°C
Storage temperature range, T _{stq}		–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. Voltage values are with respect to the anode terminal unless otherwise noted.

- 2. Maximum power dissipation is a function of $T_J(max)$, θ_{JA} , and T_A . The maximum allowable power dissipation at any allowable ambient temperature is $P_D = (T_J(max) T_A)/\theta_{JA}$. Operating at the absolute maximum T_J of 150°C can impact reliability.
- 3. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

recommended operating conditions

		MIN	MAX	UNIT
Cathode voltage, V _{KA}		V _{ref}	36	V
Cathode current, IKA		1	100	mA
Oneration free air temperature range T	TL431C, TL431AC	0	70	°C
Operating free-air temperature range, T _A	TL431I, TL431AI	-40	85	C



electrical characteristics over recommended operating conditions, T_A = 25°C (unless otherwise noted)

PARAMETER		TEST	TEST CONDITIONS I		TL431C			UNIT
		CIRCUIT			MIN	TYP	MAX	ONIT
V _{ref}	Reference voltage	2	$V_{KA} = V_{ref}$	$I_{KA} = 10 \text{ mA}$	2440	2495	2550	mV
V _{I(dev)}	Deviation of reference voltage over full temperature range (see Figure 1)	2	V _{KA} = V _{ref} , I _{KA} = T _A = full range†	10 mA,		4	25	mV
ΔV_{ref}	Ratio of change in reference voltage	3	I _{KA} = 10 mA	$\Delta V_{KA} = 10 V - V_{ref}$		-1.4	-2.7	mV
$\overline{\Delta V_{KA}}$	to the change in cathode voltage	3	IKA – IOIIIA	$\Delta V_{KA} = 36 \text{ V} - 10 \text{ V}$		-1	-2	$\frac{mV}{V}$
I _{ref}	Reference current	3	I _{KA} = 10 mA, R1 =	= 10 kΩ, R2 = ∞		2	4	μΑ
I _{I(dev)}	Deviation of reference current over full temperature range (see Figure 1)	3	I _{KA} = 10 mA, R1 = T _A = full range†	= 10 kΩ, R2 = ∞,		0.4	1.2	μА
I _{min}	Minimum cathode current for regulation	2	V _{KA} = V _{ref}			0.4	1	mA
l _{off}	Off-state cathode current	4	V _{KA} = 36 V,	V _{ref} = 0		0.1	1	μΑ
z _{KA}	Dynamic impedance (see Figure 1)	1	$I_{KA} = 1 \text{ mA to } 100$ $f \le 1 \text{ kHz}$	mA, $V_{KA} = V_{ref}$,		0.2	0.5	Ω

[†] Full range is 0°C to 70°C for the TL431C.

The deviation parameters $V_{ref(dev)}$ and $I_{ref(dev)}$ are defined as the differences between the maximum and minimum values obtained over the recommended temperature range. The average full-range temperature coefficient of the reference voltage, α_{Vref} , is defined as:

$$\left|\alpha_{Vref}\right| \left(\frac{ppm}{^{\circ}C}\right) = \frac{\left(\frac{V_{\text{I(dev)}}}{V_{ref} \text{ at } 25^{\circ}C}\right) \times 10^{6}}{\Delta T_{A}} \qquad \text{Minimum } V_{ref} \qquad \qquad V_{\text{I(dev)}} \qquad V_{\text{I(dev)}}$$

where:

 ΔT_A is the recommended operating free-air temperature range of the device.

 α_{Vref} can be positive or negative, depending on whether minimum V_{ref} or maximum V_{ref} , respectively, occurs at the lower temperature.

Example: maximum V_{ref} = 2496 mV at 30°C, minimum V_{ref} = 2492 mV at 0°C, V_{ref} = 2495 mV at 25°C, $\Delta T_A = 70^{\circ}C$ for TL431C

$$\left|\alpha_{Vref}\right| = \frac{\left(\frac{4 \text{ mV}}{2495 \text{ mV}}\right) \times 10^6}{70^{\circ}\text{C}} \approx 23 \text{ ppm/}^{\circ}\text{C}$$

Because minimum V_{ref} occurs at the lower temperature, the coefficient is positive.

Calculating Dynamic Impedance

Calculating Dynamic Impedance The dynamic impedance is defined as: $\left|z_{KA}\right| = \frac{\Delta V_{KA}}{\Delta I_{KA}}$

When the device is operating with two external resistors (see Figure 3), the total dynamic impedance of the circuit is given by:

$$|z'| = \frac{\Delta V}{\Delta I} \approx |z_{KA}| \left(1 + \frac{R1}{R2}\right)$$

Figure 1. Calculating Deviation Parameters and Dynamic Impedance



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electrical characteristics over recommended operating conditions, $T_A = 25^{\circ}C$ (unless otherwise noted)

PARAMETER		TEST	TEST CONDITIONS F		TL431I			UNIT
		CIRCUIT			MIN	TYP	MAX	ONII
V _{ref}	Reference voltage	2	$V_{KA} = V_{ref}$	$I_{KA} = 10 \text{ mA}$	2440	2495	2550	mV
V _{I(dev)}	Deviation of reference voltage over full temperature range (see Figure 1)	2	V _{KA} = V _{ref} , I _{KA} = T _A = full range†	10 mA,		5	50	mV
ΔV_{ref}	Ratio of change in reference voltage	3	I _{KA} = 10 mA	$\Delta V_{KA} = 10 \text{ V} - V_{ref}$		-1.4	-2.7	mV
$\overline{\Delta V_{KA}}$	to the change in cathode voltage	3	IKA = 10 IIIA	$\Delta V_{KA} = 36 \text{ V} - 10 \text{ V}$		-1	-2	$\frac{\text{mV}}{\text{V}}$
I _{ref}	Reference current	3	I _{KA} = 10 mA, R1 =	= 10 kΩ, R2 = ∞		2	4	μΑ
I _{I(dev)}	Deviation of reference current over full temperature range (see Figure 1)	3	I _{KA} = 10 mA, R1 = T _A = full range†	= 10 kΩ, R2 = ∞,		0.8	2.5	μΑ
I _{min}	Minimum cathode current for regulation	2	V _{KA} = V _{ref}			0.4	1	mA
loff	Off-state cathode current	4	$V_{KA} = 36 V$,	$V_{ref} = 0$		0.1	1	μΑ
z _K A	Dynamic impedance (see Figure 1)	2	$I_{KA} = 1 \text{ mA to } 100$ $f \le 1 \text{ kHz}$	mA, $V_{KA} = V_{ref}$,		0.2	0.5	Ω

[†] Full range is –40°C to 85°C for the TL431I.

electrical characteristics over recommended operating conditions, T_A = 25°C (unless otherwise noted)

PARAMETER		TEST	TEST CONDITIONS -		TL431AC			UNIT
		CIRCUIT			MIN	TYP	MAX	UNIT
V _{ref}	Reference voltage	2	$V_{KA} = V_{ref}$	$I_{KA} = 10 \text{ mA}$	2470	2495	2520	mV
V _{I(dev)}	Deviation of reference voltage over full temperature range (see Figure 1)	2	V _K A = V _{ref} , I _K A = T _A = full range†	: 10 mA,		4	25	mV
ΔV_{ref}	Ratio of change in reference voltage	3	$\Delta V_{KA} = 10 \text{ V} - V_{ref}$			-1.4	-2.7	mV
ΔV_{KA}	to the change in cathode voltage	3	$I_{KA} = 10 \text{ mA}$	$\Delta V_{KA} = 36 \text{ V} - 10 \text{ V}$		-1	-2	$\frac{mV}{V}$
I _{ref}	Reference current	3	I _{KA} = 10 mA, R1	= 10 kΩ, R2 = ∞		2	4	μΑ
l(dev)	Deviation of reference current over full temperature range (see Figure 1)	3	I _{KA} = 10 mA, R1 = T _A = full range‡	= 10 kΩ, R2 = ∞,		0.8	1.2	μΑ
I _{min}	Minimum cathode current for regulation	2	V _{KA} = V _{ref}			0.4	0.6	mA
loff	Off-state cathode current	4	V _{KA} = 36 V,	V _{ref} = 0		0.1	0.5	μΑ
z _{KA}	Dynamic impedance (see Figure 1)	1	$I_{KA} = 1 \text{ mA to } 100$ $f \le 1 \text{ kHz}$) mA, $V_{KA} = V_{ref}$,		0.2	0.5	Ω

[‡] Full range is 0°C to 70°C for the TL431AC.



electrical characteristics over recommended operating conditions, $T_A = 25$ °C (unless otherwise noted)

PARAMETER		TEST	TEST CONDITIONS I		TL431AI			UNIT
		CIRCUIT			MIN	TYP	MAX	UNIT
V _{ref}	Reference voltage	2	$V_{KA} = V_{ref}$	$I_{KA} = 10 \text{ mA}$	2470	2495	2520	mV
V _{I(dev)}	Deviation of reference voltage over full temperature range (see Figure 1)	2	V _{KA} = V _{ref} , I _{KA} = T _A = full range†	10 mA,		5	50	mV
ΔV_{ref}	Ratio of change in reference voltage	3	I _{KA} = 10 mA	$\Delta V_{KA} = 10 V - V_{ref}$		-1.4	-2.7	mV
ΔV_{KA}	to the change in cathode voltage	3	IKA = 10 IIIA	$\Delta V_{KA} = 36 \text{ V} - 10 \text{ V}$		-1	-2	$\frac{\text{mV}}{\text{V}}$
I _{ref}	Reference current	3	I _{KA} = 10 mA, R1 =	= 10 kΩ, R2 = ∞		2	4	μΑ
l _{l(dev)}	Deviation of reference current over full temperature range (see Figure 1)	3	I _{KA} = 10 mA, R1 = T _A = full range†	= 10 kΩ, R2 = ∞,		0.8	2.5	μА
I _{min}	Minimum cathode current for regulation	2	V _{KA} = V _{ref}			0.4	0.7	mA
l _{off}	Off-state cathode current	4	$V_{KA} = 36 V$,	V _{ref} = 0		0.1	0.5	μΑ
z _{KA}	Dynamic impedance (see Figure 1)	2	$I_{KA} = 1 \text{ mA to } 100$ $f \le 1 \text{ kHz}$	mA, $V_{KA} = V_{ref}$,		0.2	0.5	Ω

[†] Full range is –40°C to 85°C for the TL431AI.

electrical characteristics over recommended operating conditions, T_A = 25°C (unless otherwise noted)

PARAMETER		TEST	TEST CONDITIONS -		TL431Y			UNIT
	PARAMETER				MIN	TYP	MAX	UNIT
V _{ref}	Reference voltage	2	$V_{KA} = V_{ref}$	I _{KA} = 10 mA		2495		mV
ΔV_{ref}	Ratio of change in reference voltage	3	I _{KA} = 10 mA	$\Delta V_{KA} = 10 V - V_{ref}$		-1.4		mV
$\overline{\Delta V_{KA}}$	to the change in cathode voltage	ŭ	IKA – 10 IIIA	$\Delta V_{KA} = 36 \text{ V} - 10 \text{ V}$		-1		mV V
I _{ref}	Reference input current	3	I _{KA} = 10 mA, R1 =	: 10 kΩ, R2 = ∞		2		μΑ
I _{min}	Minimum cathode current for regulation	2	V _{KA} = V _{ref}			0.4		mA
l _{off}	Off-state cathode current	4	V _{KA} = 36 V,	$V_{ref} = 0$		0.1		μΑ
z _{KA}	Dynamic impedance‡	2	$I_{KA} = 1 \text{ mA to } 100$ $f \le 1 \text{ kHz}$	mA, $V_{KA} = V_{ref}$,		0.2		Ω

[‡] Calculating dynamic impedance:

The dynamic impedance is defined as: $|z_{KA}| = \frac{\Delta V_{KA}}{\Delta I_{KA}}$ When the device is operating with two external resistors (see Figure 3), the total dynamic impedance of the circuit is given by:

$$|z'| = \frac{\Delta V}{\Delta I} \approx |z_{KA}| \left(1 + \frac{R1}{R2}\right)$$



PARAMETER MEASUREMENT INFORMATION

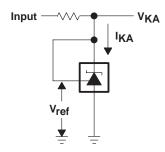


Figure 2. Test Circuit for $V_{KA} = V_{ref}$

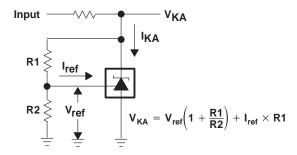


Figure 3. Test Circuit for $V_{KA} > V_{ref}$

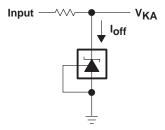


Figure 4. Test Circuit for Ioff

Table 1. Graphs

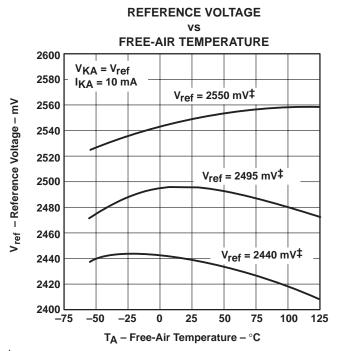
	FIGURE
Reference input voltage vs Free-air temperature	5
Reference input current vs Free-air temperature	6
Cathode current vs Cathode voltage	7, 8
Off-state cathode current vs Free-air temperature	9
Ratio of delta reference voltage to change in cathode voltage vs Free-air temperature	10
Equivalent input noise voltage vs Frequency	11
Equivalent input noise voltage over a 10-second period	12
Small-signal voltage amplification vs Frequency	13
Reference impedance vs Frequency	14
Pulse response	15
Stability boundary conditions	16

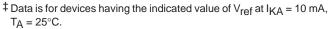
Table 2. Application Circuits

	FIGURE
Shunt regulator	17
Single-supply comparator with temperature-compensated threshold	18
Precision high-current series regulator	19
Output control of a three-terminal fixed regulator	20
High-current shunt regulator	21
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PWM converter with reference	25
Voltage monitor	26
Delay timer	27
Precision current limiter	28
Precision constant-current sink	29



TYPICAL CHARACTERISTICS[†]





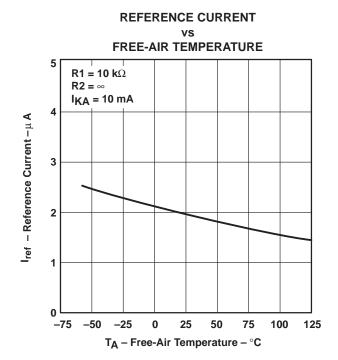
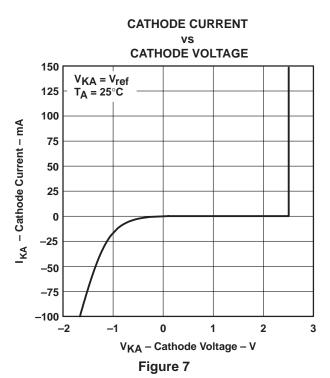
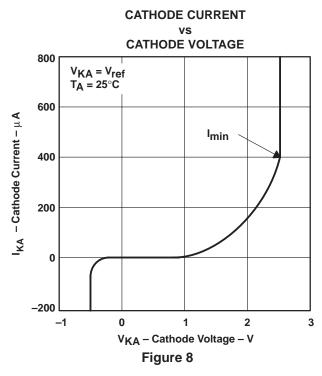


Figure 6

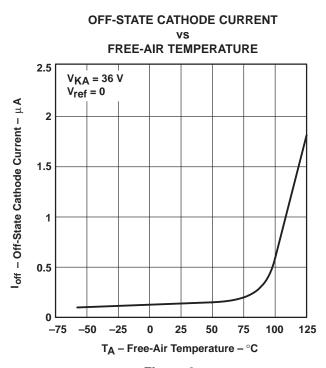






[†] Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS[†]



DELTA CATHODE VOLTAGE FREE-AIR TEMPERATURE -0.85 $V_{KA} = 3 V \text{ to } 36 V$ -0.95∆V_{ref} / ∆V_{KA}- mV/V -1.05-1.25 -1.35-1.45-75 -50 -25 25 50 75 100 125

 T_A – Free-Air Temperature – $^{\circ}C$

RATIO OF DELTA REFERENCE VOLTAGE TO

Figure 9 Figure 10

EQUIVALENT INPUT NOISE VOLTAGE

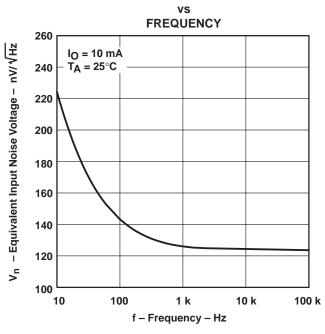
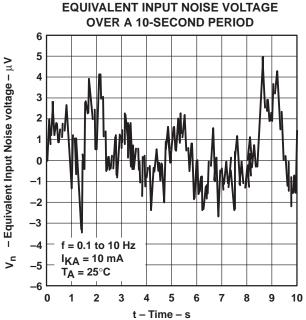


Figure 11

† Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.





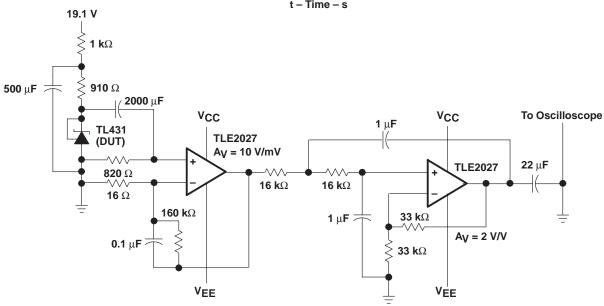
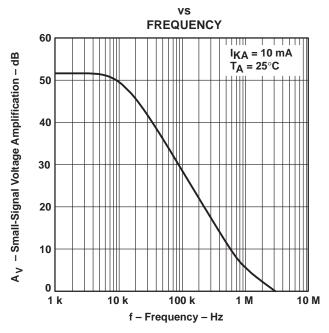
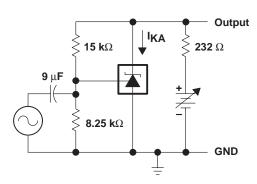


Figure 12. Test Circuit for Equivalent Input Noise Voltage

SMALL-SIGNAL VOLTAGE AMPLIFICATION

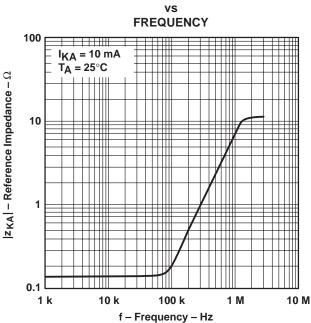


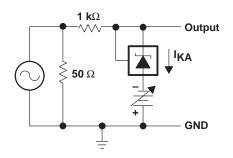


TEST CIRCUIT FOR VOLTAGE AMPLIFICATION

Figure 13

REFERENCE IMPEDANCE

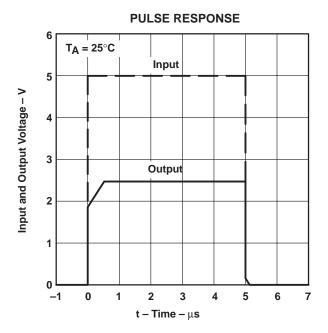


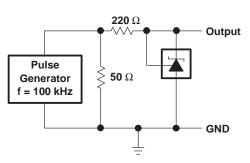


TEST CIRCUIT FOR REFERENCE IMPEDANCE

Figure 14

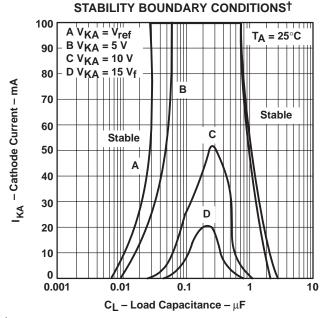




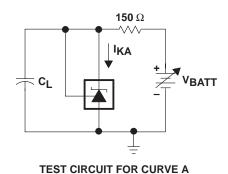


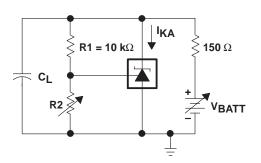
TEST CIRCUIT FOR PULSE RESPONSE

Figure 15



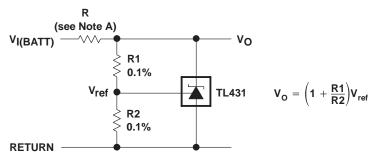
 $^{^\}dagger$ The areas under the curves represent conditions that may cause the device to oscillate. For curves B, C, and D, R2 and V+ were adjusted to establish the initial V_{KA} and I_{KA} conditions with C_L = 0. V_{BATT} and C_L were then adjusted to determine the ranges of stability.





TEST CIRCUIT FOR CURVES B, C, AND D

Figure 16



NOTE A: R should provide cathode current ≥1 mA to the TL431 at minimum V_{I(BATT)}.

Figure 17. Shunt Regulator

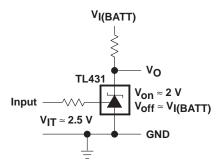
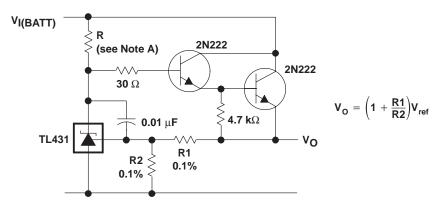


Figure 18. Single-Supply Comparator With Temperature-Compensated Threshold



NOTE A: R should provide cathode current ≥1 mA to the TL431 at minimum V_{I(BATT)}.

Figure 19. Precision High-Current Series Regulator

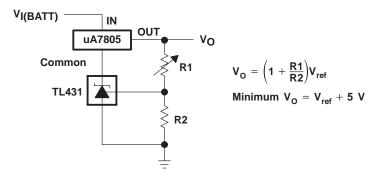


Figure 20. Output Control of a Three-Terminal Fixed Regulator

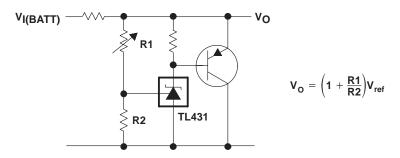
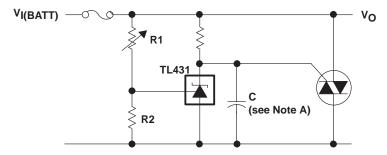


Figure 21. High-Current Shunt Regulator



NOTE A: Refer to the stability boundary conditions in Figure 16 to determine allowable values for C.

Figure 22. Crowbar Circuit

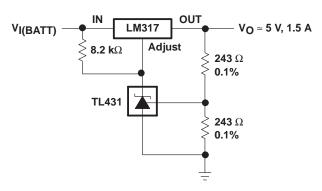
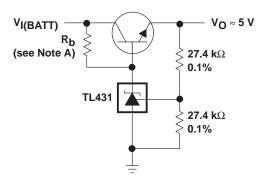


Figure 23. Precision 5-V 1.5-A Regulator



NOTE A: R_b should provide cathode current ≥1-mA to the TL431.

Figure 24. Efficient 5-V Precision Regulator

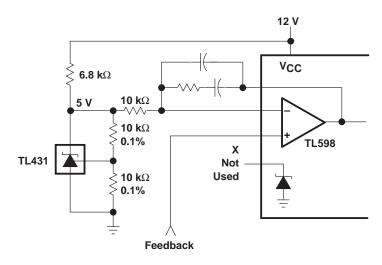
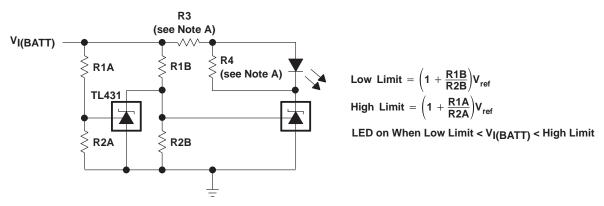


Figure 25. PWM Converter With Reference





NOTE A: R3 and R4 are selected to provide the desired LED intensity and cathode current ≥1 mA to the TL431 at the available V_{I(BATT)}.

Figure 26. Voltage Monitor

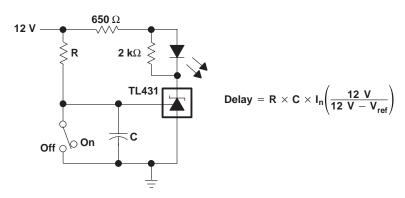


Figure 27. Delay Timer

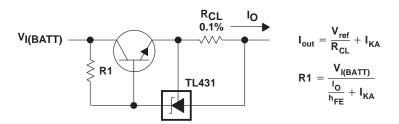


Figure 28. Precision Current Limiter

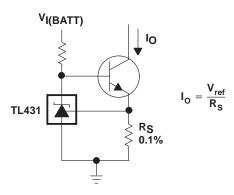


Figure 29. Precision Constant-Current Sink

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